

<b>Notice of References Cited</b>	Application/Control No. 10/569,957		Applicant(s)/Patent Under Reexamination FUIMAONO ET AL.	
	Examiner HIEN NGUYEN		Art Unit 3768	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0087329	07-2002	Massaro et al.	704/275
*	B	US-6,771,262	08-2004	Krishnan, Arun	345/424
*	C	US-6,144,875	11-2000	Schweikard et al.	600/427
*	D	US-6,556,695	04-2003	Packer et al.	382/128
*	E	US-6,128,002	10-2000	Leiper, Thomas	345/156
*	F	US-7,233,340	06-2007	Hughes et al.	345/629
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 19953308 A1	06-2000	Germany	WILLIAMS et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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